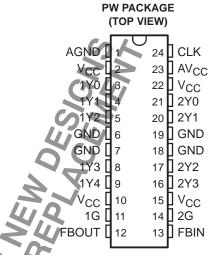
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- Use CDCVF2509A as a Replacement for this Device
- Phase-Lock Loop Clock Distribution for Synchronous DRAM Applications
- Distributes One Clock Input to One Bank of Five and One Bank of Four Outputs
- Separate Output Enable for Each Output Bank
- External Feedback (FBIN) Pin Is Used to Synchronize the Outputs to the Clock Input
- No External RC Network Required
- Operates at 3.3-V V_{CC}
- Packaged in Plastic 24-Pin Thin Shrink Small-Outline Package

NOT RECOMMENDED FOR NEW DESIGNS



description

The CDC509 is a high-performance, low-skew, low-jitter, phase-lock loop (PLL) clock driver. It uses a PLL to precisely align, in both frequency and phase, the feedback (FBOUT) output to the clock (CLK) input signal. It is specifically designed for use with synchronous DRAMs. The CDC509 operates at 3.3-V V_{CC} and is designed to drive up to five clock loads per output.

One bank of five outputs and one bank of four outputs provide nine low-skew, low-jitter copies of CLK. Output signal duty cycles are adjusted to 50 percent, independent of the duty cycle at CLK. Each bank of outputs can be enabled or disabled separately via the control (1G and 2G) inputs. When the G inputs are high, the outputs switch in phase and frequency with CLK; when the G inputs are low, the outputs are disabled to the logic-low state.

Unlike many products containing PLLs, the CDC509 does not require external RC networks. The loop filter for the PLL is included on-chip, minimizing component count, board space, and cost.

Because it is based on PLL circuitry, the CDC509 requires a stabilization time to achieve phase lock of the feedback signal to the reference signal. This stabilization time is required, following power up and application of a fixed-frequency, fixed-phase signal at CLK, as well as following any changes to the PLL reference or feedback signals. The PLL can be bypassed for test purposes by strapping AV_{CC} to ground.

The CDC509 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE

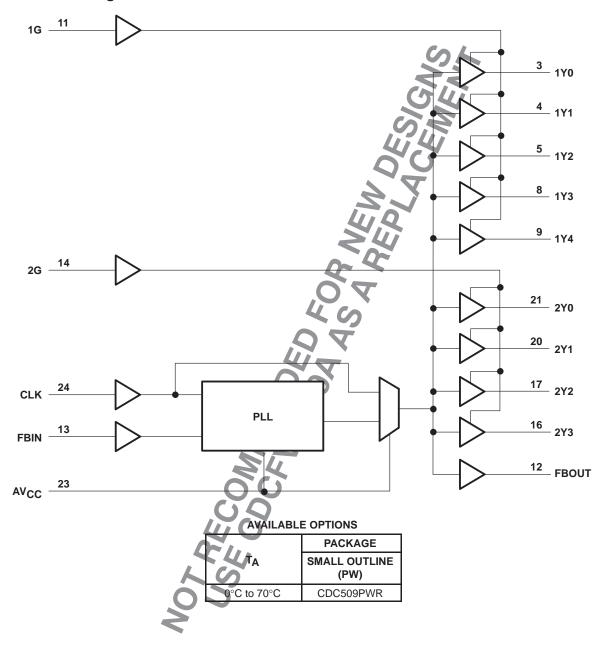
	_							
	INPUTS	;	OUTPUTS					
1G	2G	CLK	1Y (0:4)	2Y (0:3)	FBOUT			
Х	Х Х		L	L	L			
L	L	Н	L	L	Н			
L	Н	Н	L	Н	Н			
Н	L	Н	Н	L	Н			
Н	Н	Н	Н	Н	Н			



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functional block diagram





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Terminal Functions

TERMINAL			
NAME	NO.	TYPE	DESCRIPTION
CLK	24	I	Clock input. CLK provides the clock signal to be distributed by the CDC509 clock driver. CLK is used to provide the reference signal to the integrated PLL that generates the clock output signals. CLK must have a fixed frequency and fixed phase for the PLL to obtain phase lock. Once the circuit is powered up and a valid CLK signal is applied, a stabilization time is required for the PLL to phase lock the feedback signal to its reference signal.
FBIN	13	I	Feedback input. FBIN provides the feedback signal to the internal PLL. FBIN must be hard-wired to FBOUT to complete the PLL. The integrated PLL synchronizes CLK and FBIN so that there is nominally zero phase error between CLK and FBIN.
1G	11	I	Output bank enable. 1G is the output enable for outputs 1Y(0:4). When 1G is low, outputs 1Y(0:4) are disabled to a logic-low state. When 1G is high, all outputs 1Y(0:4) are enabled and switch at the same frequency as CLK.
2G	14	I	Output bank enable. 2G is the output enable for outputs 2Y(0:3). When 2G is low, outputs 2Y(0:3) are disabled to a logic low state. When 2G is high, all outputs 2Y(0:3) are enabled and switch at the same frequency as CLK.
FBOUT	12	0	Feedback output. FBOUT is dedicated for external feedback. It switches at the same frequency as CLK. When externally wired to FBIN, FBOUT completes the feedback loop of the PLL.
1Y(0:4)	3, 4, 5, 8, 9	0	Clock outputs. These outputs provide low-skew copies of CLK. Output bank 1Y(0:4) is enabled via the 1G input. These outputs can be disabled to a logic-low state by deasserting the 1G control input.
2Y(0:3)	16, 17, 20 21	0	Clock outputs. These outputs provide low-skew copies of CLK. Output bank 2Y(0:3) is enabled via the 2G input. These outputs can be disabled to a logic-low state by deasserting the 2G control input.
AVCC	23	Power	Analog power supply. AV _{CC} provides the power reference for the analog circuitry. In addition, AV _{CC} can be used to bypass the PLL for test purposes. When AV _{CC} is strapped to ground, PLL is bypassed and CLK is buffered directly to the device outputs.
AGND	1	Ground	Analog ground. AGND provides the ground reference for the analog circuitry.
VCC	2, 10, 15, 22	Power	Power supply
GND	6, 7, 18, 19	Ground	Ground

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	-0.5 V to 4.6 V
Supply voltage range, V _{CC}	-0.5 V to 6.5 V
Voltage range applied to any output in the high	
or low state, V _O (see Notes 1 and 2)	o V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$)	–50 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through each V _{CC} or GND	±100 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 3)	
Storage temperature range, T _{stq}	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 4.6 V maximum.
 - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the *ABT Advanced BiCMOS Technology Data Book*, literature number SCBD002.



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recommended operating conditions (see Note 4)

		MIN	MAX	UNIT
Vcc	Supply voltage	3	3.6	V
VIH	High-level input voltage	2		V
V_{IL}	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
ЮН	High-level output current		-20	mA
loL	Low-level output current		20	mA
TA	Operating free-air temperature	0	70	°C

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST C	CONDITIONS	V _{CC}	MIN	TYP†	MAX	UNIT
VIK	$I_{I} = -18 \text{ mA}$		3 V			-1.2	V
V	I _{OH} = -100 μA	0~ ~	MIN to MAX	V _{CC} -0.2			
Voн	$I_{OH} = -20 \text{ mA}$	0.4	3 V	2.4			٧
V	I _{OL} = 100 μA		MIN to MAX			0.2	V
V _{OL}	$I_{OL} = 20 \text{ mA}$	45	3 V			0.55	V
IĮ	$V_I = V_{CC}$ or GND	OA	3.6 V			±5	μΑ
lcc [‡]	$V_I = V_{CC}$ or GND,	$I_O = 0$, Outplus high or low	3.6 V			10	μΑ
∆lcc	One input at V _{CC} – 0.6 V,	Other inputs at V _{CC} or GND	3.3 V to 3.6 V			500	μΑ
C _i	$V_I = V_{CC}$ or GND	20	3.3 V		4		pF
Co	$V_O = V_{CC}$ or GND	17:16	3.3 V		6		pF

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

timing requirements over recommended ranges of supply voltage and operating free-air temperature

		MIN	MAX	UNIT
fclock	Clock frequency	25	125	MHz
	Input clock duty cycle	40%	60%	
	Stabilization time§		1	ms

[§] Time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. For phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at CLK. Until phase lock is obtained, the specifications for propagation delay, skew, and jitter parameters given in the switching characteristics table are not applicable.



[‡] For ICC of AVCC, see Figure 5.

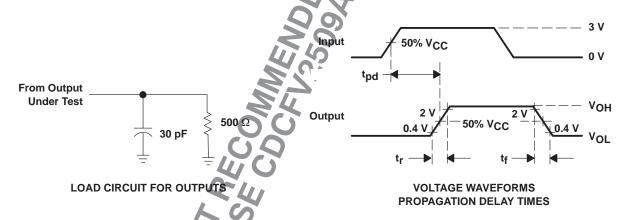
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 30 \text{ pF}$ (see Note 5 and Figures 1 and 2)[†]

PARAMETER	FROM	TO (OUTPUT)	V _{CC} = 3.3 V ± 0.165 V	\	/ _{CC} = 3.3 V ± 0.3 V	UNIT
	(INPUT)	(OUTPUT)	MIN TYP MAX	MIN	TYP MAX	
t _{phase error} , reference (see Figure 3)	66 MHz < CLKIN↑ < 100 MHz	FBIN↑		V	100480	ps
^t phase error, – jitter, (see Note 6)	CLKIN↑ = 100 MHz	FBIN↑	220 480		340	ps
t _{sk(o)} ‡	Any Y or FBOUT	Any Y or FBOUT	W.W		200	ps
Jitter _(pk-pk)	F(clkin > 66 MHz)	Any Y or FBOUT	0.0	-100	100	ps
Duty cycle, reference	F(clkin ≤ 66 MHz)	Any Y or FBOUT	7	45%	55%	
(see Figure 4)	F(clkin > 66 MHz)	Any Y or FBOUT	27	43%	57%	
t _r		Any Y or FBOUT	1.1 1.5	0.7	1.6	ns
t _f		Any Y or FBOUT	0.8 1.3	0.5	1.5	ns

[†]This parameters are not production tested.

5. The specifications for parameters in this table are applicable only after any appropriate stabilization time has elapsed.
6. Phase error does not include jitter. The total phase error is 120 ps to 580 ps for the 5% V_{CC} range.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 100 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 1.2 ns. $t_f \leq$ 1.2 ns.
- C. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

 $[\]ddagger$ The $t_{Sk(0)}$ specification is only valid for equal loading of all outputs.

PARAMETER MEASUREMENT INFORMATION

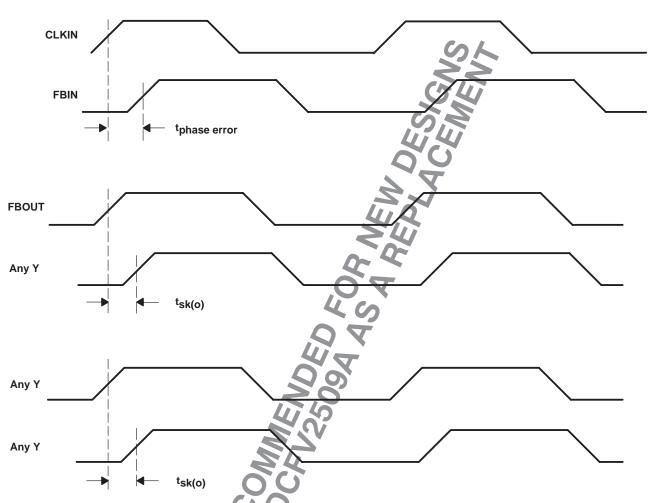
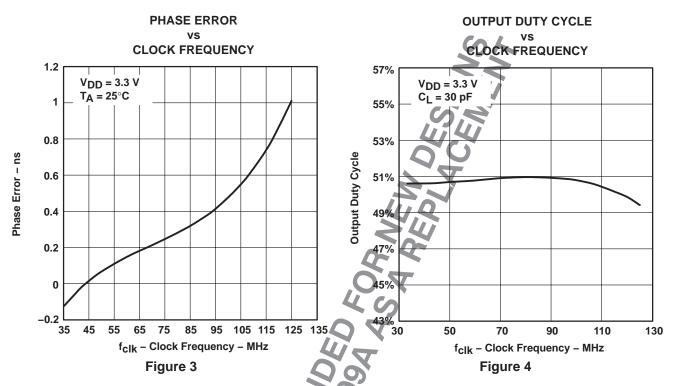


Figure 2. Phase Error and Skew Calculations



TYPICAL CHARACTERISTICS



ANALOG SUPPLY CURRENT vs CLOCK FREQUENCY

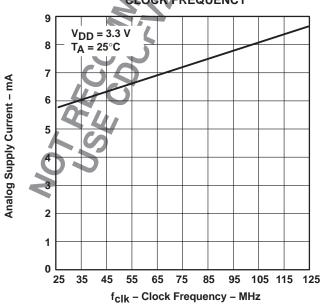


Figure 5

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
CDC509PWR	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	CK509
CDC509PWR.B	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	CK509
CDC509PWRG4	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	CK509

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

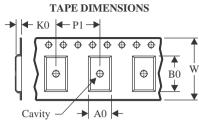
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





_	<u> </u>
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	` '	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
١	CDC509PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

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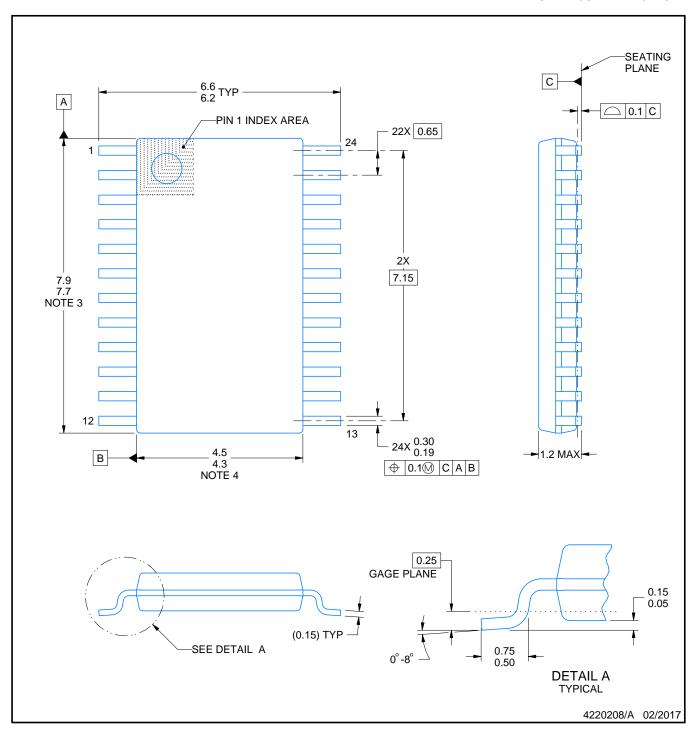


*All dimensions are nominal

Ì	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ı	CDC509PWR	TSSOP	PW	24	2000	353.0	353.0	32.0



SMALL OUTLINE PACKAGE



NOTES:

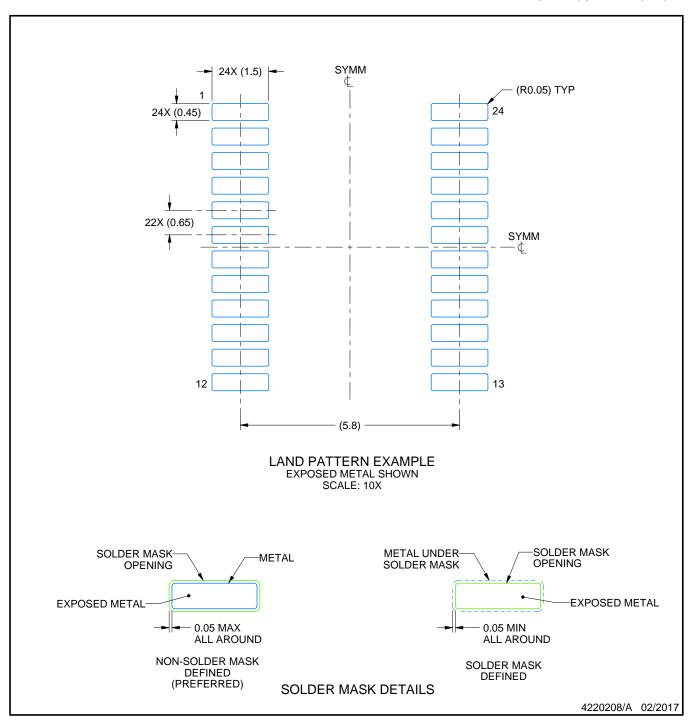
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



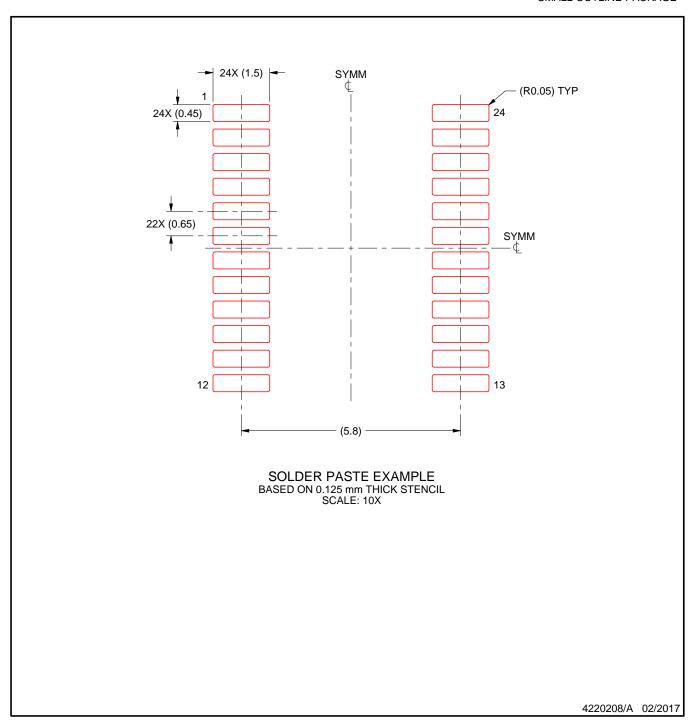
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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